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The Radiation Monitoring System for the LHC and LHC Experimental Areas

Ch. Ilgner, May 4 2004

Beam condition monitoring

- protecting LHC experiments
- tests of CVD diamond sensors

Radiation monitors for the LHC experimental caverns

- various active and passive sensors

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The Beam Condition Monitor (BCM)

Outline:

Beam condition monitor (BCM)

Accident scenarios

CVD diamond

Test results

Layout (CMS)

Radiation monitors

Active sensors

Passive sensors

Purpose of the BCM:

provide real-time radiation monitoring within CMS and ATLAS (others are welcome) to detect and initiate protection procedures for detector subsystems at the onset of beam instabilities and accidents

Goal:

provide monitoring information in the time scale of the LHC beam structure of 25ns → beam dump request, detector HV ramp down

Sensor candidate:

CVD diamond close to beam pipe, at a distance of about 1.5m from the interaction points. Fast electronics outside the main volume



BCM: accident scenarios – unsynchronized beam abort

Outline:

Beam
condition
monitor
(BCM)

Accident
scenarios

CVD diamond

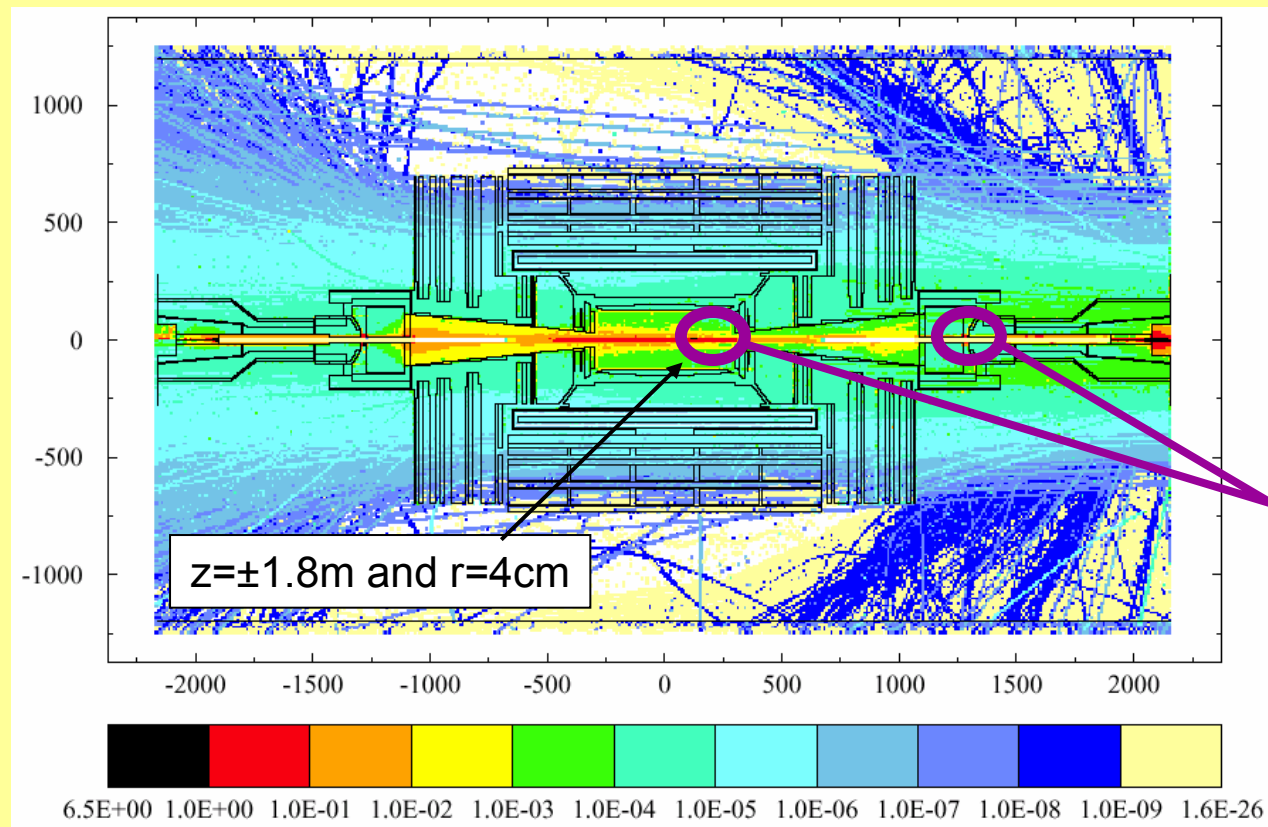
Test results

Layout (CMS)

Radiation
monitors

Active
sensors

Passive
sensors



Possible
BCM
sensor
locations
in CMS

after M. Huhtinen

Doses in Gy over 260ns throughout the CMS spectrometer

Ch. Ilgner, CERN TS/LEA, TS workshop, May 4-6, 2004



BCM: accident scenarios – resulting doses

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Loss type	Dose per event (on inner Si strip layer of CMS tracker)	Flux factor	ratio
Unsynchronized beam abort	10 mGy	1	1
One 7 TeV proton lost on TAS	15 pGy	10^{12}	1500*
One 450 GeV proton lost on TAS	1 pGy	10^{12}	100*

after A. Macpherson

Unsynchronized beam abort : 10^{12} protons lost in IP5 over 260 ns

Dose rates up to 1000 times higher if consecutive full bunches lost

Ch. Ilgner, CERN TS/LEA, TS workshop, May 4-6, 2004



BCM: accident scenarios – time scales

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sensors

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sensors

Name	Operation mode	Loss type	Loss location	ΔT /turns
D1 warm	collision	local	triplet/collimator	5
damper	injection	local	arc/triplet	6
warm quadrupoles	any	distributed	collimator	18
dump septum	any	local	diluter kicker/septum	35
warm orbit corrector	collision	local	triplet/collimator	55
RF (?)	any	local	arc/triplet/septum	55
D1 warm	injection	local	arg/triplet/collimators	120
D1 Cold	collision	local	triplet/collimator	220
warm orbit corrector	injection	local	arc/triplet/collimator	250
MB quench	collision	local	triplet/collimator	280

after A. Macpherson

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BCM: accident scenarios – D1 magnet failure

Outline:

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monitor
(BCM)

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scenarios

CVD diamond

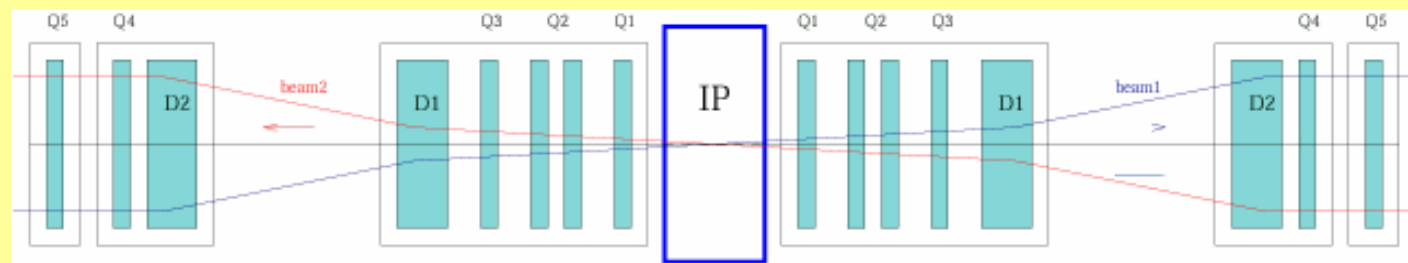
Test results

Layout (CMS)

Radiation
monitors

Active
sensors

Passive
sensors



after V. Kain, R. Schmidt, R. Assmann, EPAC 2002

D1 magnet failure:

fastest generic beam-loss scenario, timescale: 5 turns ~ 500 ns

→ defines the response time scale

information from BCM need to be provided on a bunch-by-bunch basis, a few 100 ns for decision on beam dump

Ch. Ilgner, CERN TS/LEA, TS workshop, May 4-6, 2004



BCM: CVD diamond

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monitors

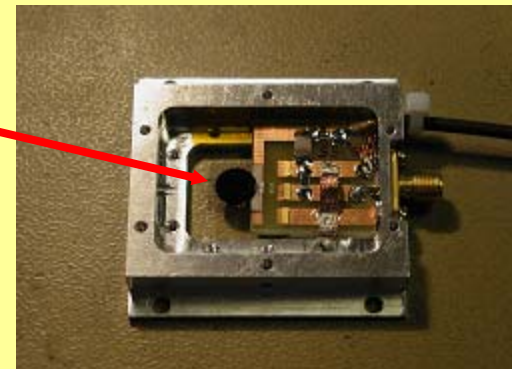
Active
sensors

Passive
sensors

CVD (chemically vapor deposition) diamond:

- promising BCM sensor candidate
- 1 x 1 cm polycrystalline material, typically 300 μm thick
- operation similar to Si, but charge traps need to be filled up
- radiation hard

metallization,
8mm in diameter





BCM: CVD diamond

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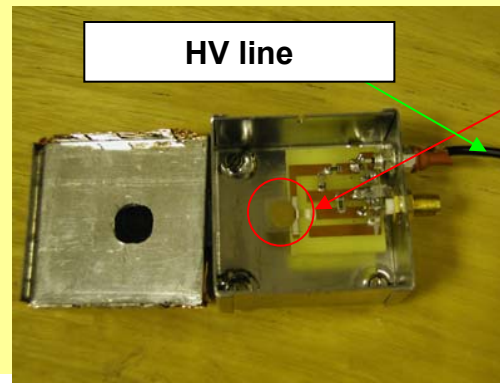
Test results

Layout (CMS)

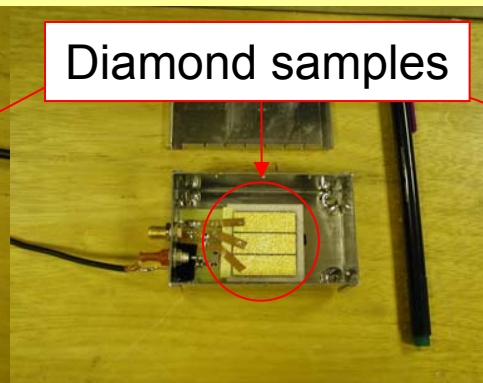
Radiation monitors

Active sensors

Passive sensors

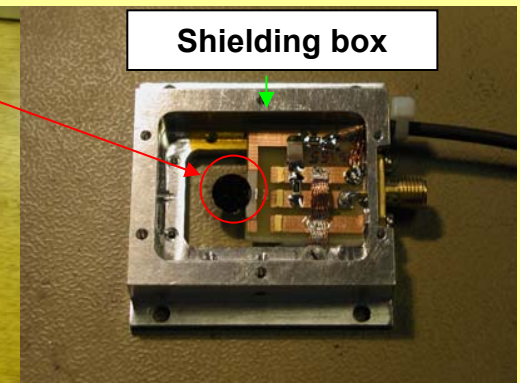


CDS126: 1x1cmx300 um thick
Collection dist ~ 110 um

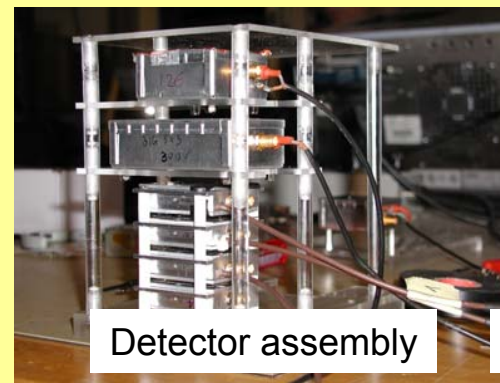


Diamond samples

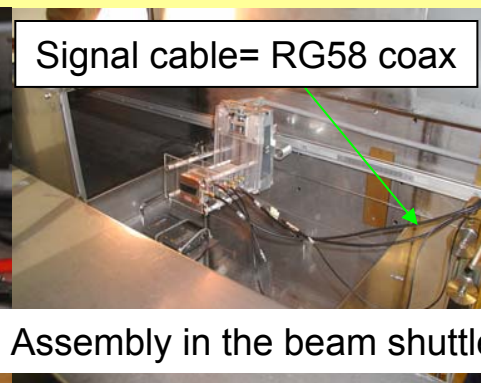
3x1cmx500 um thick
Collection dist ~ 40 um



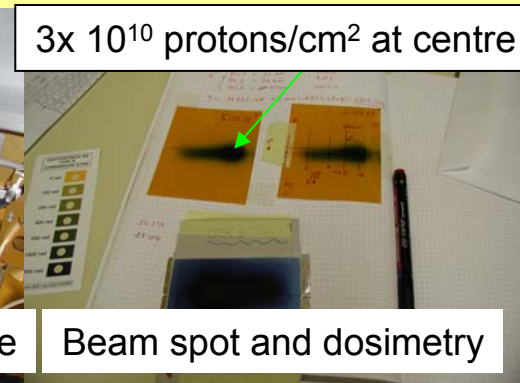
CDS116: 1x1cmx500 um thick
Collection dist ~ 125 um



Detector assembly



Assembly in the beam shuttle



3×10^{10} protons/cm² at centre

Beam spot and dosimetry



BCM: beam-test results

Outline:

Beam condition monitor (BCM)

Accident scenarios

CVD diamond

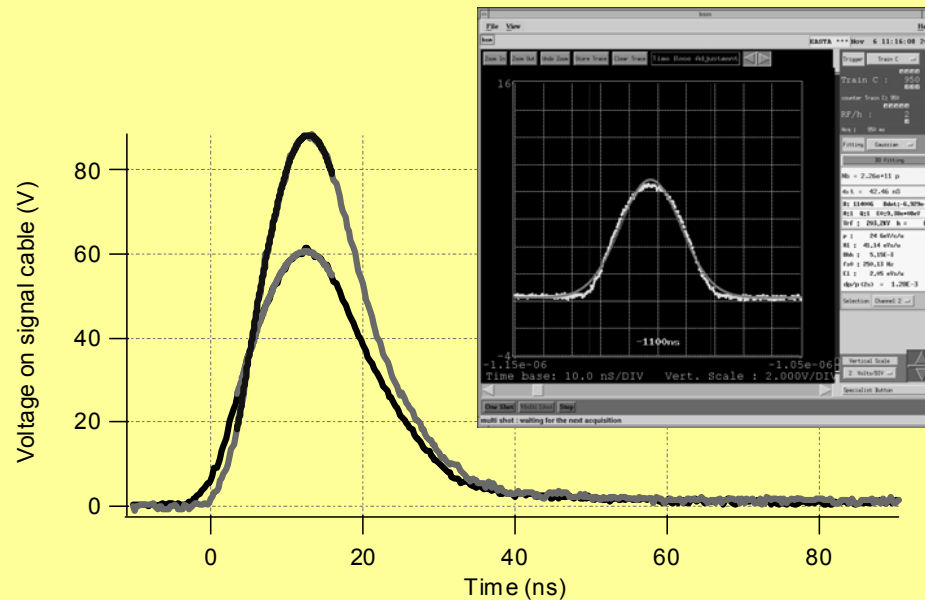
Test results

Layout (CMS)

Radiation monitors

Active sensors

Passive sensors



Diamond response to a single shot: sufficiently fast, but the Gaussian tail is not yet understood



BCM: beam-test results

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Accident
scenarios

CVD diamond

Test results

Layout (CMS)

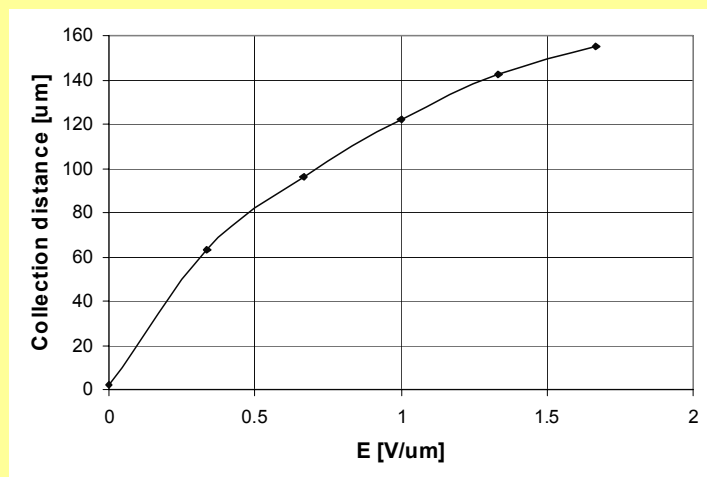
Radiation
monitors

Active
sensors

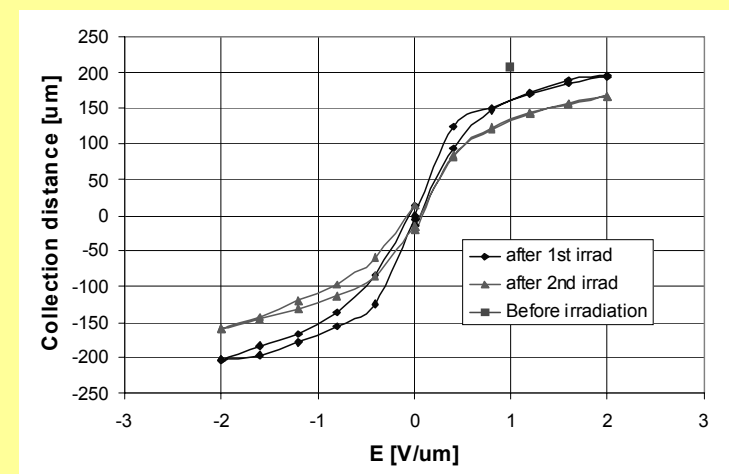
Passive
sensors

(charge) collection distance: $\delta = \frac{Q_C}{Q_G} \cdot d$, a quality parameter

δ as a function of the electric field for two CVD diamond samples:



300 μm thick CVD, unirradiated



500 μm thick CVD, unirradiated
and after 10^{15} and additional
 2.8×10^{15} protons/cm²



BCM: beam-test results

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scenarios

CVD diamond

Test results

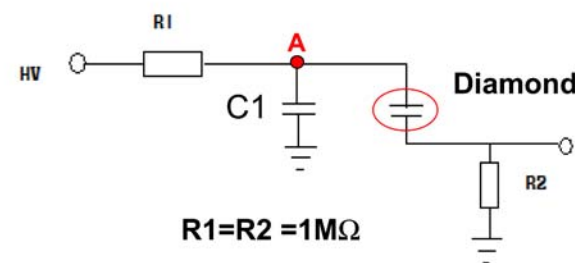
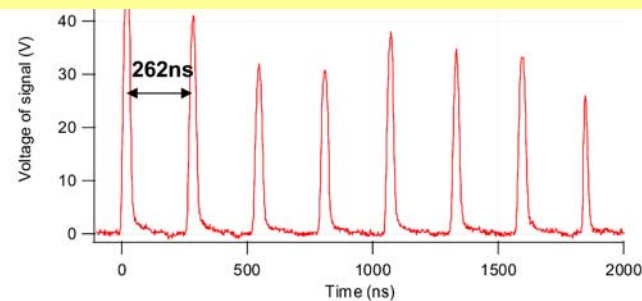
Layout (CMS)

Radiation
monitors

Active
sensors

Passive
sensors

multiple bunches

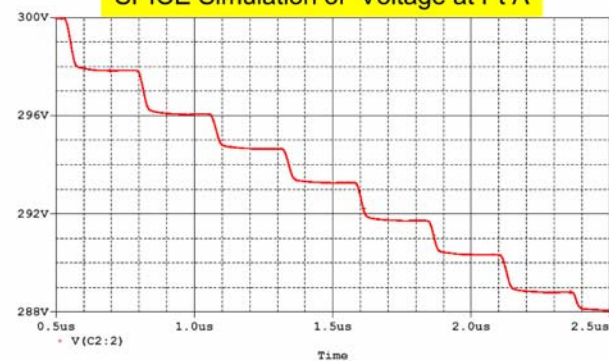


C1 acts as a reservoir capacitor
=>The larger the value the longer the bias
field on the can be maintained.
=>Bunch amplitude variation is real

C1(CDS126)=15 nF
C1 is sufficiently large to maintain bias
across the diamond for the 8 bunches.

C1R1 time constant ~15 ms
=> recharging of C1 is slow compared to
bunch structure

SPICE Simulation of Voltage at Pt A





BCM: sensors inside the CMS spectrometer

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scenarios

CVD diamond

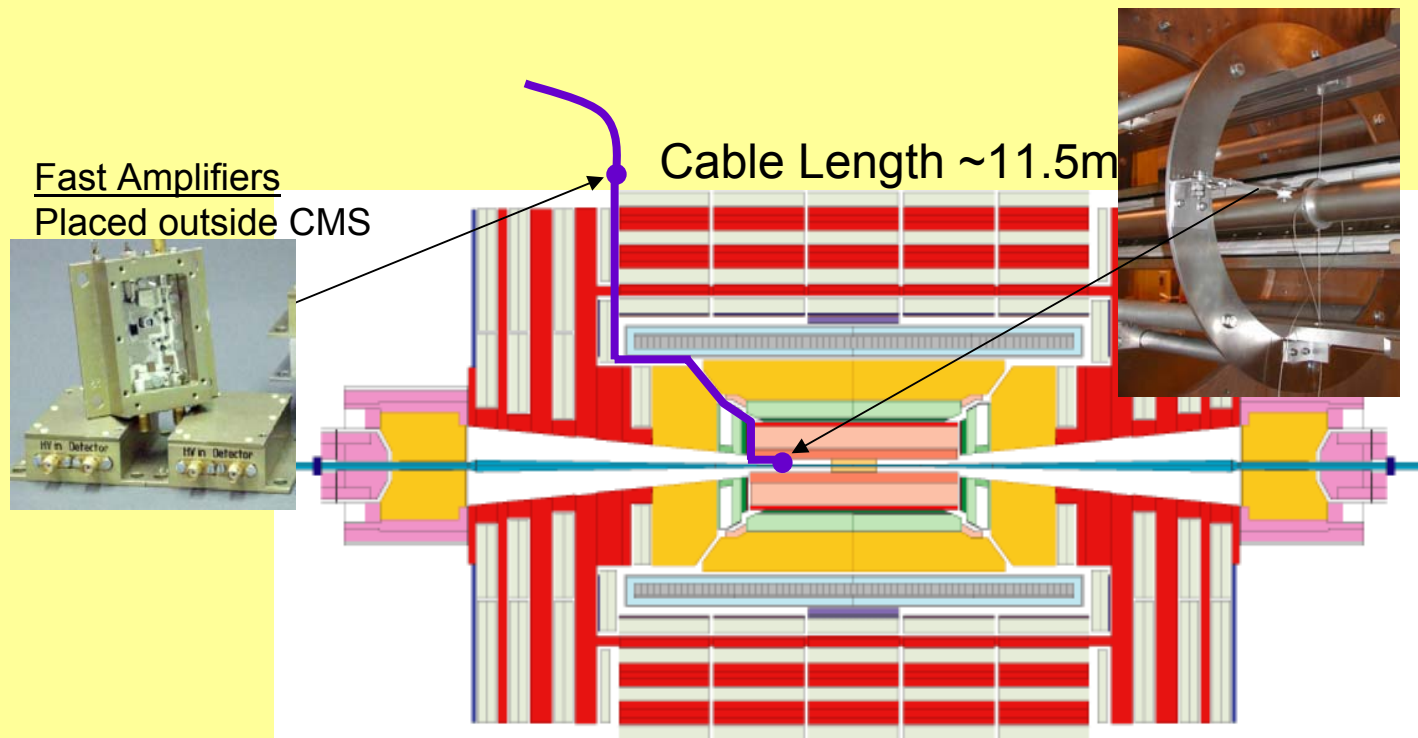
Test results

Layout (CMS)

Radiation
monitors

Active
sensors

Passive
sensors





Radiation monitors: active sensors

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Beam
condition
monitor
(BCM)

Accident
scenarios

CVD diamond

Test results

Layout (CMS)

Radiation
monitors

Active
sensors

Passive
sensors

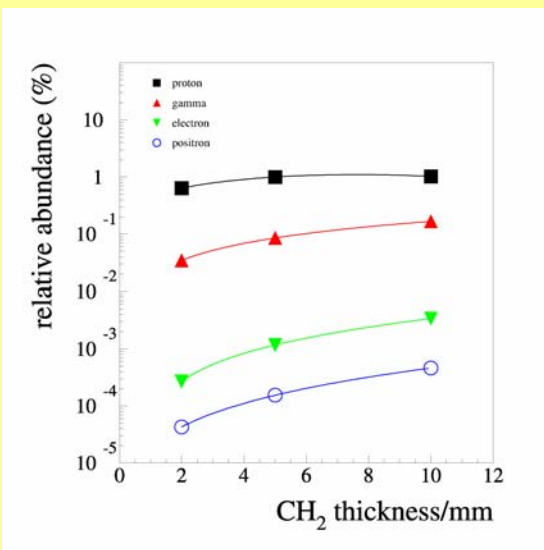
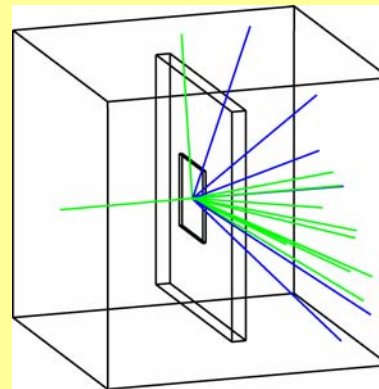
RadFET dosimeters

- p-channel MOS transistors used to measure the ionizing dose via a charge build-up in the SiO₂ layer of the device.
- growth of the transistor threshold voltage V_{th} is proportional to the deposited dose when a constant current passes through the device
- integrating dosimeters for long-term measurements

GEANT4 simulation:

polyethylene sensor
housing influences the
detector response

agrees with simulation
results



Ch. Ilgner, CERN TS/LEA, TS workshop, May 4-6, 2004



Radiation monitors: active sensors

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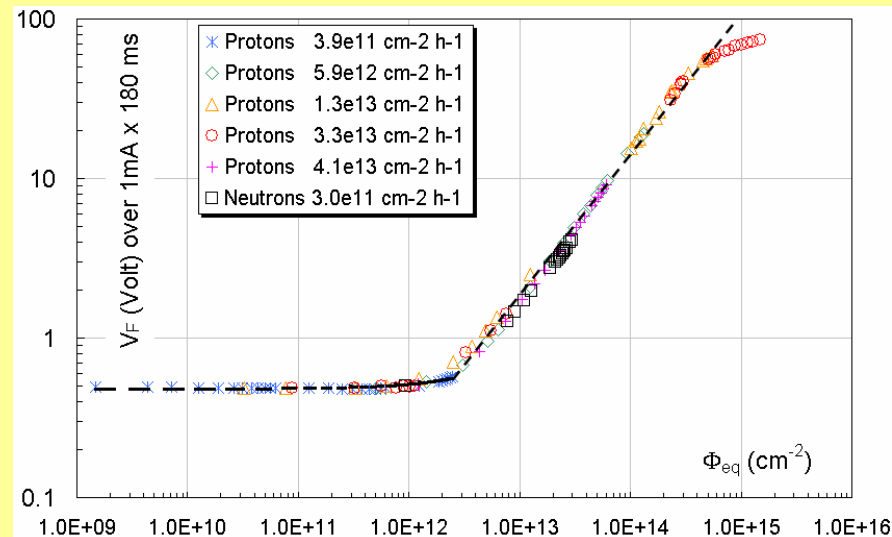
Radiation
monitors

Active
sensors

Passive
sensors

p-i-n diodes

Radiation causes displacement damage in the bulk silicon material, as well as macroscopic effects, like an increase in Si resistivity and leakage current, both proportional to the received particle fluence



Irradiation response of the OSRAM BPW34F diodes that were tested in forward bias operation applying a current pulse of 1mA over 180ms for the readout.



Radiation monitors: passive sensors

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scenarios

CVD diamond

Test results

Layout (CMS)

Radiation
monitors

Active
sensors

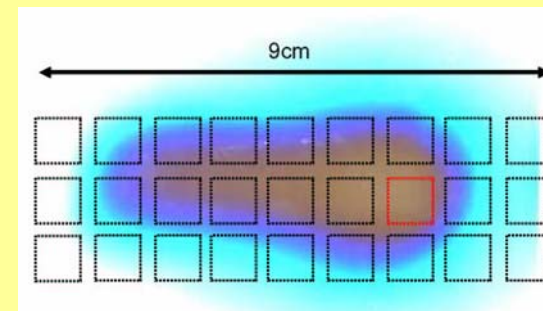
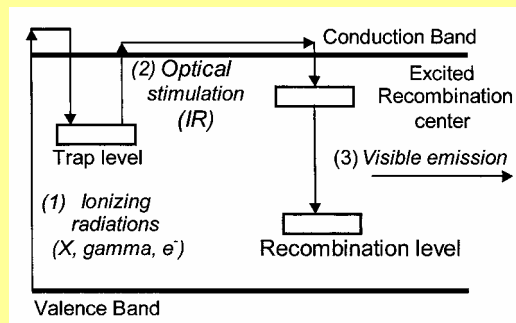
Passive
sensors

Long-term radiation monitoring, several techniques are available:

- polymer-alanine (PAD)
- TLD (thermoluminescence dosimeter)
- radio-photo luminescent (RPL) dosimeters

→ formation of stable free radicals (PAD) or color centers (RPL) after irradiation. For readout, they have to be removed. The necessary readout instrumentation and know-how is already in use at CERN (SC/RP department).

- OSL: optically stimulated luminescence: used in BCM test beam development of an automatic readout system in progress



BCM test
beam data
(M. Glaser,
F. Ravotti)



Conclusion

CVD diamond

is a promising candidate for an LHC beam-condition monitor, capable of withstanding the radiation doses and particle fluence rates such a system will have to deal with.

Its response is sufficiently fast to react on a bunch-by-bunch basis.

A variety of active and passive radiation sensors

is being investigated in collaboration with PH/TA1, in view of the complicated radiation environment in the LHC experimental caverns.